Notice of References Cited Application/Control No. 09/920,549 Examiner LaShanya R Nash Applicant(s)/Patent Under Reexamination LIN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0138625 A1	09-2002	Bruner et al.	709/227
	В	US-2002/0114317 A1	08-2002	Dorenbosch et al.	370/352
	С	US-6,760,757 B1	07-2004	Lundberg et al.	709/217
	D	US-6,295,457 B1	09-2001	Narayanaswamy, Shankar	455/466
	Е	US-6,747,692 B2	06-2004	Patel et al.	348/211.2
	F	US-6,314,108 B1	11-2001	Ramasubramani et al.	370/465
	G	US-6,289,212 B1	09-2001	Stein et al.	455/412.1
	Н	US-6,016,318	01-2000	Tomoike, Hiroyuki	370/401
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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